DATA SHEET



MOS FIELD EFFECT TRANSISTOR NP55N04SUG

SWITCHING N-CHANNEL POWER MOSFET

DESCRIPTION

The NP55N04SUG is N-channel MOS Field Effect Transistor designed for high current switching applications.

ORDERING INFORMATION

PART NUMBER	PACKAGE
NP55N04SUG	TO-252 (MP-3ZK)

FEATURES

<R>

- Channel temperature 175 degree rating
- Super low on-state resistance

 $R_{DS(on)}$ = 6.5 m Ω MAX. (VGS = 10 V, ID = 28 A)

• Low input capacitance

Ciss = 3400 pF TYP. (VDS = 25 V)

(TO-252)



ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

	Drain to Source Voltage (VGS = 0 V)	VDSS	40	V
	Gate to Source Voltage (VDS = 0 V)	Vgss	±20	V
	Drain Current (DC) (Tc = 25°C)	I _{D(DC)}	±55	Α
	Drain Current (pulse) Note1	ID(pulse)	±220	Α
>	Total Power Dissipation (Tc = 25°C)	P _{T1}	77	W
	Total Power Dissipation (T _A = 25°C)	P _{T2}	1.2	W
	Channel Temperature	Tch	175	°C
	Storage Temperature	T _{stg}	-55 to +175	°C
	Repetitive Avalanche Current Note2	lar	30	Α
	Repetitive Avalanche Energy Note2	Ear	90	mJ

Notes 1. PW \leq 10 μ s, Duty Cycle \leq 1%

2. Tch \leq 150°C, VdD = 20 V, Rg = 25 Ω , Vgs = 20 \rightarrow 0 V

THERMAL RESISTANCE

<R> Channel to Case Thermal Resistance °C/W 1.95 Rth(ch-C) Channel to Ambient Thermal Resistance °C/W 125 Rth(ch-A)

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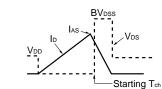
ELECTRICAL CHARACTERISTICS (TA = 25°C)

CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	IDSS	V _{DS} = 40 V, V _{GS} = 0 V			1	μΑ
Gate Leakage Current	Igss	V _{GS} = ±20 V, V _{DS} = 0 V			±100	nA
Gate to Source Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250 μA	2.0	3.0	4.0	V
Forward Transfer Admittance Note	y fs	V _{DS} = 10 V, I _D = 28 A	12	23		S
Drain to Source On-state Resistance Note	R _{DS(on)}	V _{GS} = 10 V, I _D = 28 A		5.0	6.5	mΩ
Input Capacitance	Ciss	V _{DS} = 25 V,		3400	5100	pF
Output Capacitance	Coss	V _{GS} = 0 V,		320	480	pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		210	380	pF
Turn-on Delay Time	t _{d(on)}	V _{DD} = 20 V, I _D = 28 A,		30	66	ns
Rise Time	tr	V _{GS} = 10 V,		52	130	ns
Turn-off Delay Time	t _{d(off)}	R _G = 0 Ω		78	156	ns
Fall Time	tr			12	30	ns
Total Gate Charge	Q _G	V _{DD} = 32 V,		63	95	nC
Gate to Source Charge	Qgs	V _{GS} = 10 V,		12		nC
Gate to Drain Charge	Q _{GD}	I _D = 55 A		20		nC
Body Diode Forward Voltage Note	V _{F(S-D)}	I _F = 55 A, V _{GS} = 0 V		0.94	1.5	V
Reverse Recovery Time	trr	I _F = 55 A, V _{GS} = 0 V,		37		ns
Reverse Recovery Charge	Qrr	di/dt = 100 A/ <i>μ</i> s		40		nC

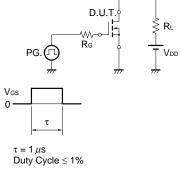
Note Pulsed

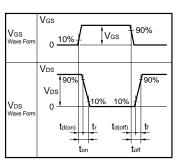
TEST CIRCUIT 1 AVALANCHE CAPABILITY

$V_{GS} = 20 \rightarrow 0 \text{ V}$ $V_{GS} = 20 \rightarrow 0 \text{ V}$ V_{DU} V_{DD} V_{DD} V_{DD} V_{DD} V_{DD}



TEST CIRCUIT 2 SWITCHING TIME

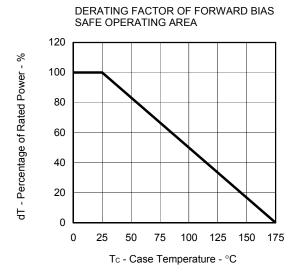


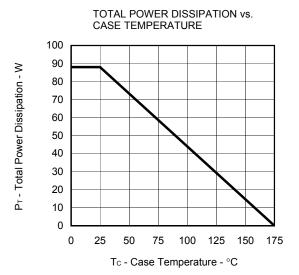


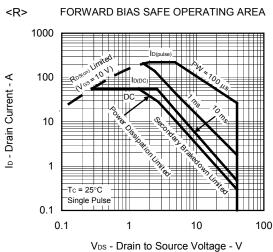
TEST CIRCUIT 3 GATE CHARGE

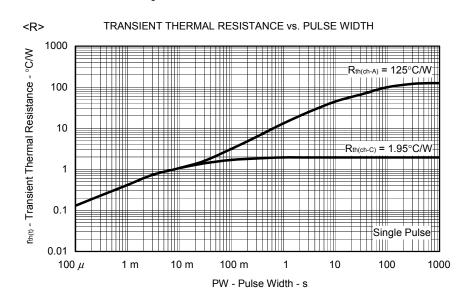
$$\begin{array}{c|c} D.U.T. \\ I_G = 2 \ \underline{m} A \\ \hline W - o \end{array} \begin{array}{c} R_L \\ \hline V_{DD} \end{array}$$

TYPICAL CHARACTERISTICS (TA = 25°C)

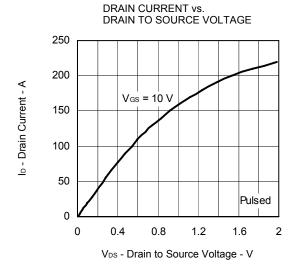


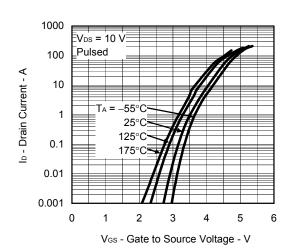






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FORWARD TRANSFER CHARACTERISTICS

CHANNEL TEMPERATURE Ves(th) - Gate to Source Threshold Voltage - V 3.5 3 2.5 2 1.5 1 $V_{DS} = V_{GS}$ 0.5 I_D = 250 μA 0

0

50

 T_{ch} - Channel Temperature - $^{\circ}C$

100

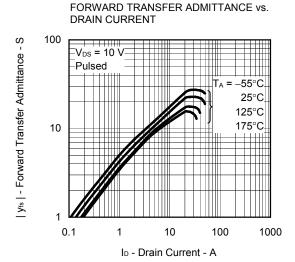
150

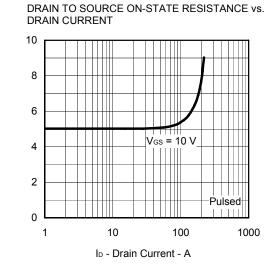
200

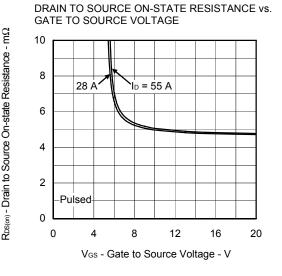
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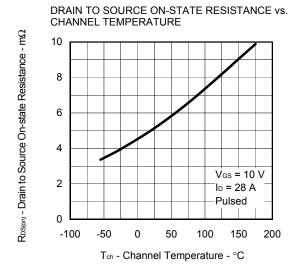
-50

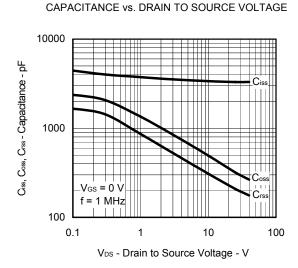
GATE TO SOURCE THRESHOLD VOLTAGE vs.

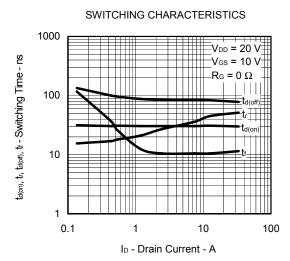


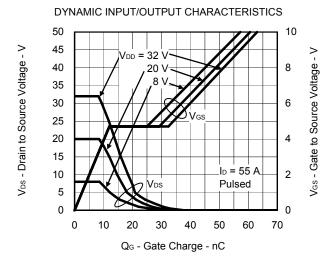


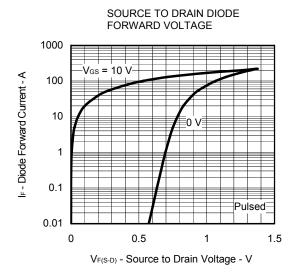


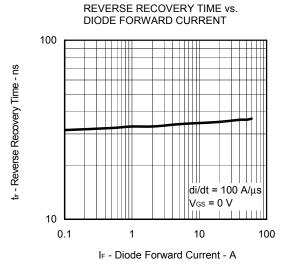




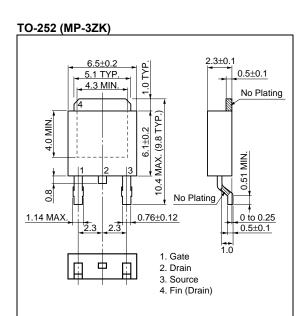




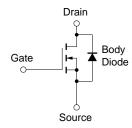




PACKAGE DRAWING (Unit: mm)



EQUIVALENT CIRCUIT



Remark Strong electric field, when exposed to this device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop generation of static electricity as much as possible, and quickly dissipate it once, when it has occurred.

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